

STD35NF06L

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STD35NF06L	60V	<0.017Ω	35A

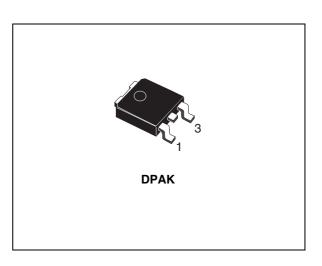
- Low threshold drive
- Gate charge minimized

Description

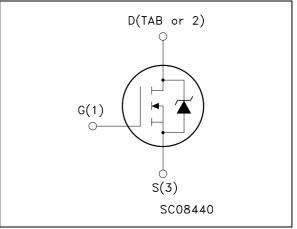
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

Applications

Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STD35NF06LT4	D35NF06L	DPAK	Tape & reel

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Electrical ratings

Table 1.	Absolute maxim	um ratings
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Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage ($V_{GS} = 0$)	60	V
V _{DGR}	Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)	60	V
V _{GS}	Gate- source voltage	± 16	V
I _D	Drain current (continuous) at $T_C = 25^{\circ}C$	35	A
I _D	Drain current (continuous) at $T_C = 100^{\circ}C$	24.5	A
I _{DM} ⁽¹⁾	Drain current (pulsed)	140	A
P _{tot}	Total dissipation at $T_C = 25^{\circ}C$	80	W
	Derating Factor	0.67	W/°C
dv/dt ⁽²⁾	Peak diode recovery avalanche energy	5	V/ns
E _{AS} ⁽³⁾	Single pulse avalanche energy	280	mJ
T _{stg}	Storage temperature		°C
Тj	Max. operating junction temperature	– -55 to 175	U

1. Pulse width limited by safe operating area.

2. I_{SD} \$5A, di/dt \leq 00A/ μ s, V_{DD} =V(_{BR)DSS}, $T_j \leq T_{JMAX}$

3. Starting $T_j = 25$ °C, $I_D = 30A$, $V_{DD} = 30V$

	Table	2.	Thermal	data
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Rthj-case	Thermal resistance junction-case max	1.88	°C/W
Rthj-amb	mb Thermal resistance junction-to ambient max		°C/W
TJ	Maximum lead temperature for soldering purpose	275	°C

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

	• • • • • • • • • • • • • • • • • • • •					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 250µA, V _{GS} =0	60			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = Max rating V_{DS} = Max rating, T_{C} = 125°C			1 10	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 16V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1			V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 17.5A$ $V_{GS} = 4.5V, I_D = 17.5A$		0.014 0.016	0.017 0.020	Ω Ω

Table 3. On/off states

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V, I _D = 17.5A		28		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25V, f = 1MHz, V _{GS} = 0		1700 305 105		pF pF pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 30V, I_D = 27.5A$ $R_G = 4.7\Omega V_{GS} = 4.5V$ (see <i>Figure 12</i>)		20 100 40 20		ns ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 48V, I_D = 55A,$ $V_{GS} = 4.5V, R_G = 4.7\Omega$ (see <i>Figure 13</i>)		25 5 10	33	nC nC nC

1. Pulsed: Pulse duration = $300 \ \mu s$, duty cycle 1.5%.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				35 140	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 35A, V _{GS} = 0			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 35A, di/dt = 100A/µs, V_{DD} = 30V, T_j = 150°C (see <i>Figure 14</i>)		80 200 5		ns nC A

Table 5.Source drain diode

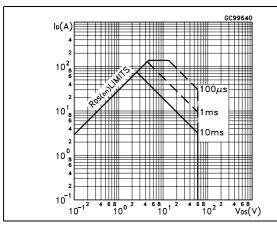
1. Pulse width limited by safe operating area.

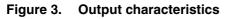
2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

Figure 1. Safe operating area





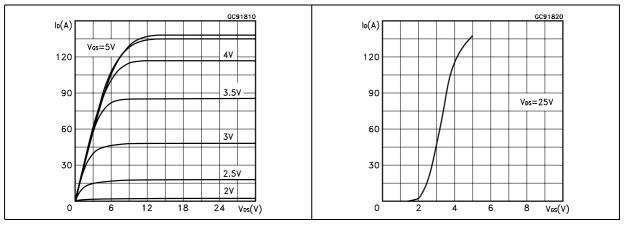
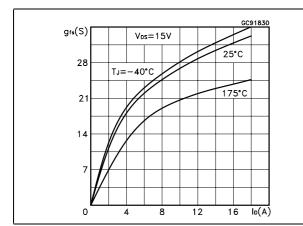
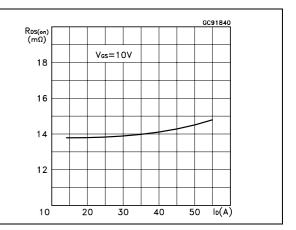


Figure 2.





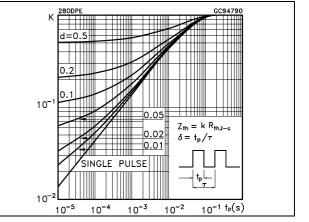




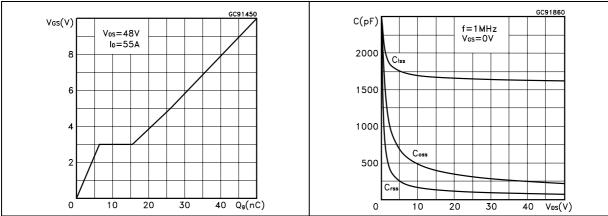
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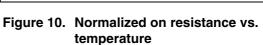


Thermal impedance



Gate charge vs. gate-source voltage Figure 8. **Capacitance variations** Figure 7.

Figure 9. Normalized gate threshold voltage vs. temperature



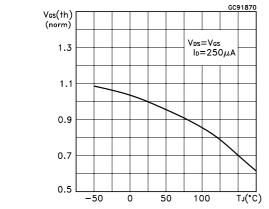
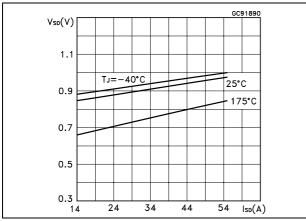
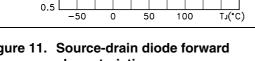
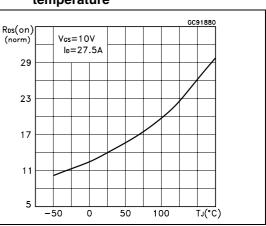


Figure 11. Source-drain diode forward characteristics





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3 Test circuit

Figure 12. Switching times test circuit for resistive load

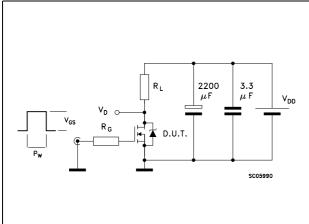
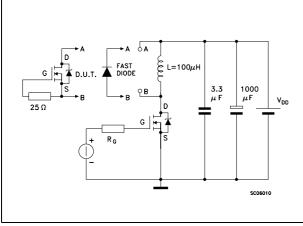


Figure 14. Test circuit for inductive load switching and diode recovery times





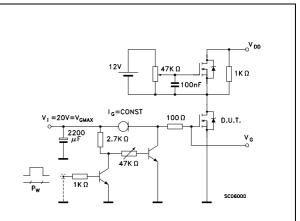
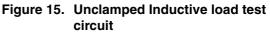


Figure 13. Gate charge test circuit



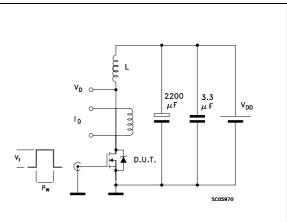
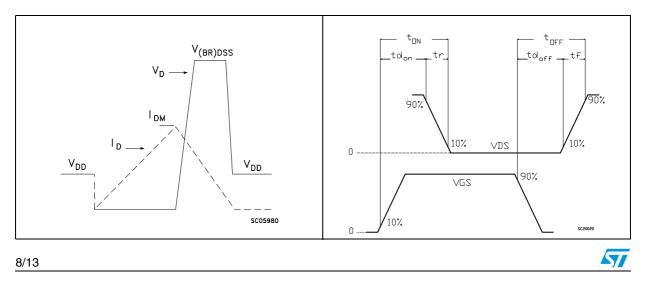


Figure 17. Switching time waveform



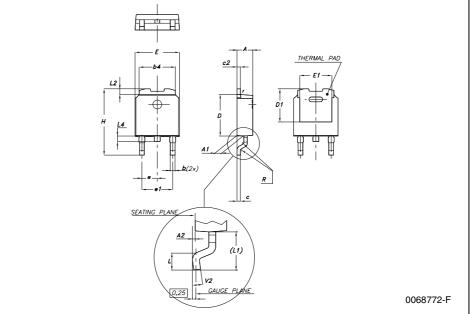
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



DIM.		mm.			inch	
DINI.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX.
А	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A2	0.03		0.23	0.001		0.009
В	0.64		0.9	0.025		0.035
b4	5.2		5.4	0.204		0.212
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
D1		5.1			0.200	
Е	6.4		6.6	0.252		0.260
E1		4.7			0.185	
е		2.28			0.090	
e1	4.4		4.6	0.173		0.181
Н	9.35		10.1	0.368		0.397
L	1			0.039		
(L1)		2.8			0.110	
L2		0.8			0.031	
L4	0.6		1	0.023		0.039
R		0.2			0.008	
V2	0°		8°	0°		8°
		I				

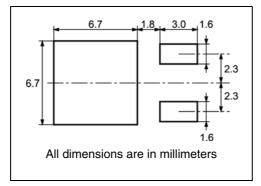
DPAK MECHANICAL DATA

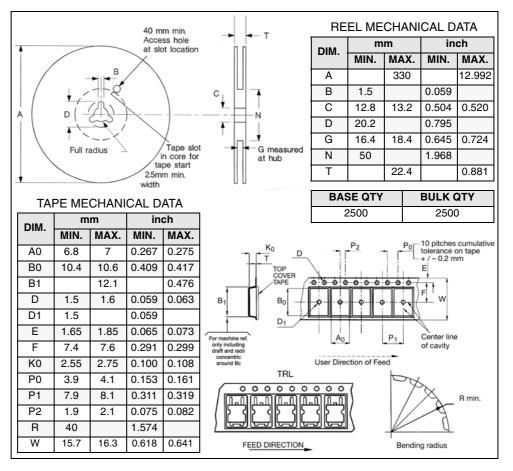




5 Packing mechanical data

DPAK FOOTPRINT





TAPE AND REEL SHIPMENT

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6 Revision history

Table 6.	Revision	history
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Date	Revision	Changes
21-Jun-2004	2	Preliminary version
06-Jul-2006	3	New template, no content change
20-Feb-2007	4	Typo mistake on page 1



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